


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590850	<b>Applicant(s)/Patent Under Reexamination</b>  FUJISAWA ET AL.
	<b>Examiner</b>  Cho, Jennifer Y	<b>Art Unit</b>  1621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Search	11/19/07	LH
East Search	11/19/07	JC
Inventor Search	11/19/07	JC
Updated East Search	6/6/08	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner